

DynaFiz is a new instantaneous Fizeau-type interferometer optimized for dynamic metrology in the presence of extreme vibrations and air turbulence. Mx<sup>™</sup> software with LivePhase<sup>™</sup> enables real-time Zernike analysis for active alignment and dynamic testing.

### SYSTEM OVERVIEW

Measurement Capability

Measures surface form of reflective materials and optics, and transmitted wavefront of transparent optics

Measurement **Techniques** 

PSI - temporal phase-shifting

interferometry

QPSI - vibration robust temporal phase-

shifting interferometry

DynaPhase™ - vibration insensitive instantaneous interferometry

Alignment System

DynaPhase alignment wizard with

integrated calibration

Quick Fringe Acquisition System (QFAS)

with twin spot reticle for PSI

Test Beam Diameter

4 inch (102 mm) or 6 inch (152 mm)

Alignment FOV

4 inch: ±3 degrees 6 inch: ±2 degrees 4.25 in. (108 mm)

Optical Centerline Camera Details

Resolution: 1200 x 1200 /600 x 600 pixels

Frame Rate: 50 Hz /82 Hz

Digitization: 10 bit

Magnification 1X Fixed (1-50X digital);

3 Position Zoom Turret 1X/1.7X/3X

Polarization Nominally circular (1.2:1 or better)

Pupil Focus Range

4 inch: ±2 m 6 inch: ±4.5 m

Computer and

High-performance Dell PC, Windows 10

Software 64-bit and Mx software

Mounting Configuration Horizontal or vertical

Remote Control

Wired and wireless remote with common

interferometer function controls

Ontion

CARS (Coherent Artifact Suppression)-

minimizes artifacts from wavefront

shearing, speckle, or mottle

See the ZYGO Laser Interferometer Accessories

Accessory Guide, OMP-0463

Physical Envelope

69 x 31 x 34 cm (LWH) (27.3 x 12.1 x 13.4 in.)

Weight ≤90 lb (41 kg)

Warranty 3 years laser source, 2 years system

# LASER DETAILS

Laser Source

High power stabilized HeNe

Class

IIIa (meets 3R ANSI requirements)

Wavelength

633 nm

Frequency Stabilization

<0.0001 nm

Output Power

>3 mW >100 m

Coherence Length

**UTILITY REQUIREMENTS** 

Power

100 to 240 VAC, 50/60 Hz

Compressed Air

80 psi (5.5 bar); dry and filtered source (required for optional vibration isolation) dynafiz. **Specifications** 



### OPERATIONAL ENVIRONMENT<sup>(1)</sup>

Vibration Isolation

15 to 30°C (59 to 86°F) Temperature

Rate of Temp. Change <1.0°C per 15 min

Humidity

5 to 95% relative, non-condensing Not required for DynaPhase acquisition; recommended with PSI acquisition

## PERFORMANCE 2

**RMS Simple** Repeatability 3

 $< 0.06 \text{ nm}, \lambda/10,000 (2\sigma)$ 

**RMS Wavefront** Repeatability 4

Dynamic: <1.0 nm,  $\lambda/600$  (mean +  $2\sigma$ ) PSI/QPSI: <0.25 nm,  $\lambda$ /2500 (mean + 2 $\sigma$ ) Dynamic: <2.0 nm,  $\lambda/300$  (99.5<sup>th</sup> %)

Peak Pixel Deviation 5 PSI/QPSI: <0.5 nm,  $\lambda/1200$  (99.5<sup>th</sup> %)

Dynamic: 250 fringes (all magnifications) Fringe Resolution 6

PSI/QPSI: 500 fringes (all magnifications)

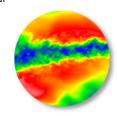
**Exposure Time** 12 µsec (minimum)

LivePhase Real-time phase with Zernike fit Phase Movies Records events ≤82 frames/sec and

generates AVI movie and raw data file

External Movie Trigger TTL signal





- 1. Defines conditions under which the system can operate; does not represent environmental stability required to meet specified performance.
- Performance qualified with the temperature set point between 20-23° C.
- 3. RMS Simple Repeatability is defined by 2X the std dev of the RMS for 36 sequential measurements (16 avgs) of a short plano cavity at 1X zoom.
- 4. RMS Wavefront Repeatability is defined by the mean RMS difference plus 2X the standard deviation for the differential between all even numbered measurements and a synthetic reference (defined as the average of all odd numbered measurements); 36 sequential measurements (16 averages) at 1X zoom form the basis for calculation.
- 5. Peak Pixel Deviation is defined by the 99.5th percentile of the pixel-wise std dev map for 36 sequential measurements (16 averages); this result measures time varying behavior (or Type A uncertainties) at 1X zoom.
- 6. The approximate number of tilt fringes in the part image that can be resolved by the interferometer.



Distribution in the UK & Ireland



Characterisation, Measurement & **Analysis** 

Lambda Photometrics Limited

Lambda House Batford Mill Harpenden Herts AL5 5BZ United Kingdom

info@lambdaphoto.co.uk w٠ www.lambdaphoto.co.uk +44 (0)1582 764334 T:

+44 (0)1582 712084

Specifications subject to change without prior notice.